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Application/Control No.	Applicant(s)/Patent under Reexamination
10/757,725	UEYAMA ET AL.
Examiner	Art Unit
Thomas H Parsons	1745

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SEARCHED					
Class	Subclass	Date	Examiner		
429	30 44	11/27/2006	THP		
427	115	11/27/2006	THP		
502	101	11/27/2006	тнр		
updated	above Search	5/7/2007	THY		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference History Pr	Search intout	5/7/2007	7111

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor Name Search Updated	11/27/2006 5/7/2 <i>0</i> 07	ТНР <i>ТНР</i>
East (USPAT, USOCR, JPO, EPO, Derwent, IBM_TDB) see search history printout	11/27/2006	THP